

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Jong Shik YOON et al. Confirmation No.: 8658
Application Number : 10/825,343
Filed : April 15, 2004
Title : MINIMIZING TRANSISTOR VARIATIONS DUE TO SHALLOW
TRENCH ISOLATION STRESS
TC/Art Unit : 2813
Examiner: : Thanh T. Nguyen

Docket No. : TI-37043 (0025.0245)
Customer No. : 23494

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

REPLY TO OFFICE ACTION

In reply to the Office Action mailed January 29, 2008, please amend the
above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims in this paper.

Remarks/Arguments follow the amendment sections of this paper.